NSN 6625-00-923-6534

T228-a

Semiconductor Device Test Set - Page 1 of 1



View Online at https://aerobasegroup.com/nsn/6625-00-923-6534 Width: 6.000 inches Length: 8.187 inches **Internal Battery Accommodation:** Included **Inclosure Feature:** Single item w/carrying case **Test Type For Which Designed:** Front resistance of crystal; back resistance of crystal; back current of crystal **Operating Test Capability:** Front resistance-not greater than 0.5 kilohm for a good crystal; back resistance-ratio of back to front resistance greater than 10 to 1 for a good crystal; back current-crystal should not indicate current greater than - crystal in21 and in23, in25, in21a and in23b, in21b, in26 we, in 26 syl, in 78 syl - current d. C. 0.400 ma, 0.300 ma, 0.250 ma, 0.175 ma, 0.125 ma, 0.110 ma, 0.230 ma, 0.160 ma Height: 3.625 inches Shelf Life: N/a **Unit Of Measure: Demilitarization:** No Fiig: